



Atty. Dkt. No. MIT-C205

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

Applicant: OKU, YUICHI *et al.*

Title: KITS AND METHODS FOR DETECTING OR MEASURING ANALYTES

Appl. No. 10/070,161

Filing Date: March 4, 2002

Examiner: Gary Counts

Art Unit: 1641

**RESPONSE TO OFFICE ACTION OF MARCH 29, 2005**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

Responsive to the office action of March 29, 2005, please amend the captioned application as follows: